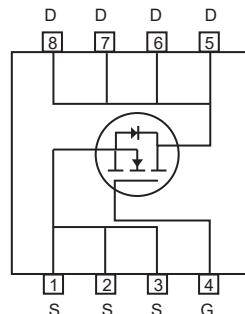
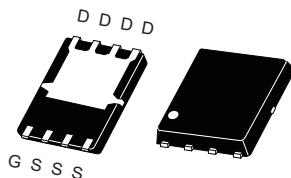


N-Channel Enhancement Mode Field Effect Transistor**FEATURES**

- 60V, 87A, $R_{DS(ON)} = 5.5m\Omega$ @ $V_{GS} = 10V$.
- Super high dense cell design for extremely low $R_{DS(ON)}$.
- High power and current handing capability.
- Lead-free plating ; RoHS compliant.
- Surface mount Package.



P-PAK 5X6

ABSOLUTE MAXIMUM RATINGS $T_A = 25^\circ C$ unless otherwise noted

Parameter	Symbol	Limit	Units
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous	$I_D @ R_{\theta JA}$	24	A
Drain Current-Continuous	$I_D @ R_{\theta JC}$	87	A
Drain Current-Pulsed ^a	$I_{DM} @ R_{\theta JA}$	96	A
Drain Current-Pulsed ^a	$I_{DM} @ R_{\theta JC}$	348	A
Maximum Power Dissipation	P_D	83	W
Single Pulsed Avalanche Energy ^e	E_{AS}	162	mJ
Single Pulsed Avalanche Current ^e	I_{AS}	60	A
Operating and Store Temperature Range	T_J, T_{stg}	-55 to 150	°C

Thermal Characteristics

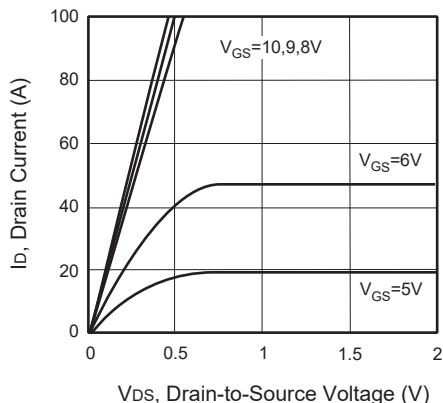
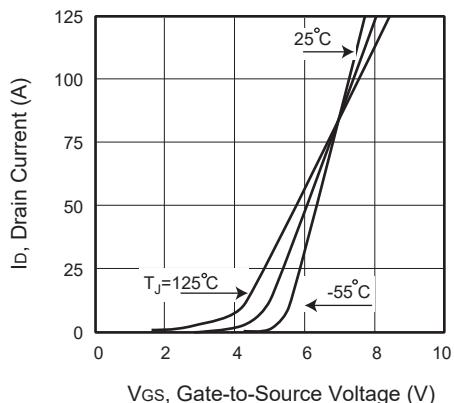
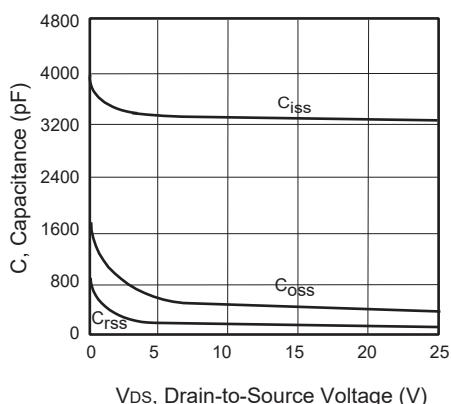
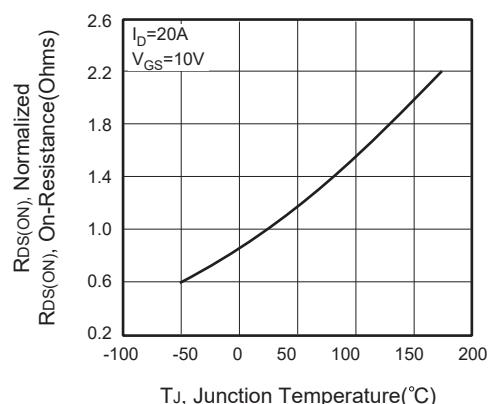
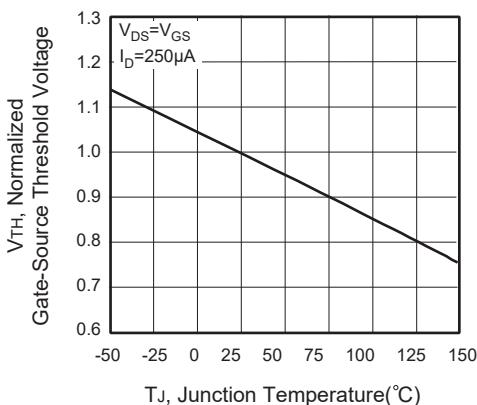
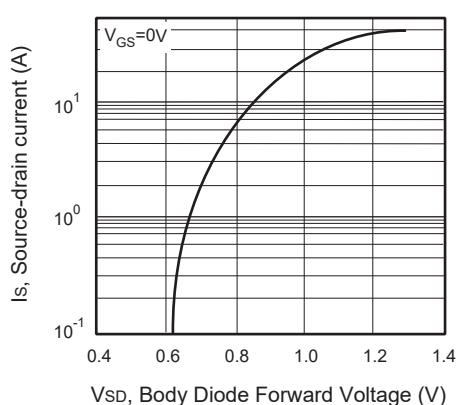
Parameter	Symbol	Limit	Units
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	1.5	°C/W
Thermal Resistance, Junction-to-Ambient ^b	$R_{\theta JA}$	20	°C/W



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Electrical Characteristics $T_A = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	60			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}} = 60\text{V}, V_{\text{GS}} = 0\text{V}$			1	μA
Gate Body Leakage Current, Forward	I_{GSSF}	$V_{\text{GS}} = 20\text{V}, V_{\text{DS}} = 0\text{V}$			100	nA
Gate Body Leakage Current, Reverse	I_{GSSR}	$V_{\text{GS}} = -20\text{V}, V_{\text{DS}} = 0\text{V}$			-100	nA
On Characteristics^c						
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}} = V_{\text{DS}}, I_D = 250\mu\text{A}$	2		4	V
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 10\text{V}, I_D = 20\text{A}$		4.6	5.5	$\text{m}\Omega$
Gate input resistance	R_g	f=1MHz,open Drain		3		Ω
Dynamic Characteristics^d						
Input Capacitance	C_{iss}	$V_{\text{DS}} = 25\text{V}, V_{\text{GS}} = 0\text{V}, f = 1.0 \text{ MHz}$		3215		pF
Output Capacitance	C_{oss}			375		pF
Reverse Transfer Capacitance	C_{rss}			215		pF
Switching Characteristics^d						
Turn-On Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 30\text{V}, I_D = 50\text{A}, V_{\text{GS}} = 10\text{V}, R_{\text{GEN}} = 3.6\Omega$		27	54	ns
Turn-On Rise Time	t_r			15	30	ns
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$			58	116	ns
Turn-Off Fall Time	t_f			15	30	ns
Total Gate Charge	Q_g	$V_{\text{DS}} = 48\text{V}, I_D = 50\text{A}, V_{\text{GS}} = 10\text{V}$		77	100	nC
Gate-Source Charge	Q_{gs}			15		nC
Gate-Drain Charge	Q_{gd}			30		nC
Drain-Source Diode Characteristics and Maximum Ratings						
Drain-Source Diode Forward Current ^b	I_S				80	A
Drain-Source Diode Forward Voltage ^c	V_{SD}	$V_{\text{GS}} = 0\text{V}, I_S = 20\text{A}$			1	V
Notes :						
a.Repetitive Rating : Pulse width limited by maximum junction temperature.						
b.Surface Mounted on FR4 Board, t ≤ 10 sec.						
c.Pulse Test : Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.						
d.Guaranteed by design, not subject to production testing.						
e.L = 0.09mH, $I_{\text{AS}} = 60\text{A}, V_{\text{DD}} = 25\text{V}, R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$						

**Figure 1. Output Characteristics****Figure 2. Transfer Characteristics****Figure 3. Capacitance****Figure 4. On-Resistance Variation with Temperature****Figure 5. Gate Threshold Variation with Temperature****Figure 6. Body Diode Forward Voltage Variation with Source Current**

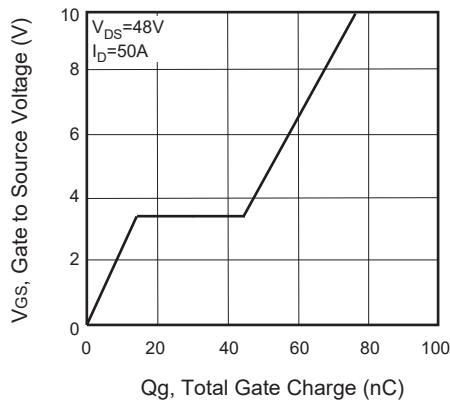


Figure 7. Gate Charge

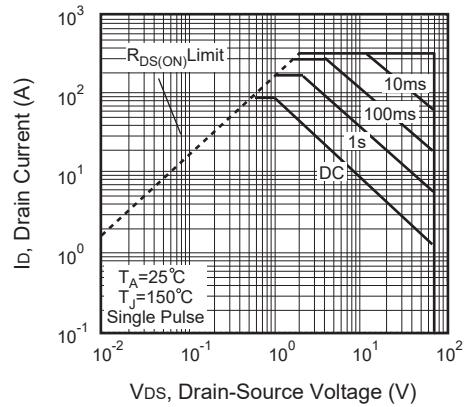


Figure 8. Maximum Safe Operating Area

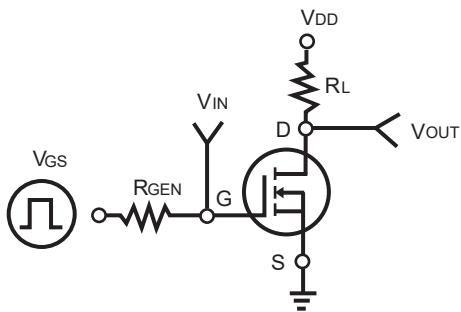


Figure 9. Switching Test Circuit

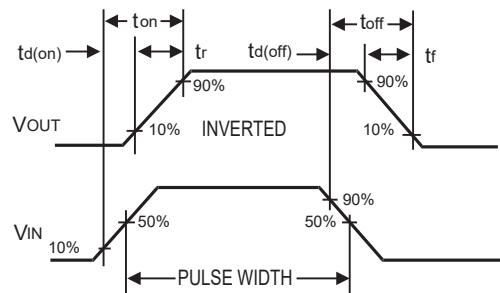


Figure 10. Switching Waveforms

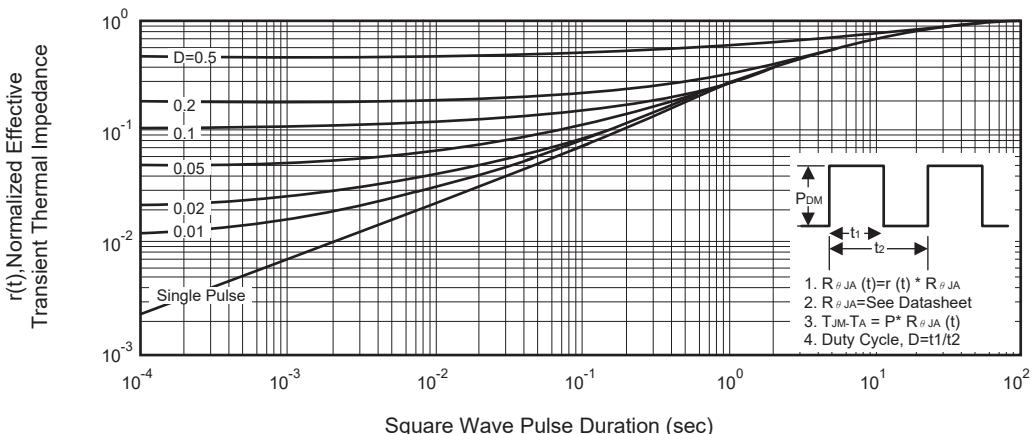


Figure 11. Normalized Thermal Transient Impedance Curve